

Application/Control	No.
10/700.216	

SCHANTZ, JOHN L.

Examiner Benny Q. Tieu Art Unit 2614

Applicant(s)/Patent under Reexamination

			ISSUE	CL	.AS	SIF	ICAT	ON						
	ORIGI	NAL		INTERNATIONAL CLASSIFICATION										
	CLASS	.ASS			CL	AIMED		NON-CL	NON-CLAIMED					
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	CROSS REF	ERENCES						,		,				
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(Legai Ins	struments Examin	(Primary Examiner) (Date)						2						

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	5			35			65			95			125			155			185
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